

Computer Architecture

Lecture 6a: ChargeCache

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ChargeCache

Reducing DRAM Latency by Exploiting Row Access Locality

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Executive Summary

- **Goal**: Reduce average DRAM access latency with no modification to the existing DRAM chips
- **Observations**:
 - 1) A highly-charged DRAM row can be accessed with low latency
 - 2) A row's charge is restored when the row is accessed
 - 3) A recently-accessed row is likely to be accessed again:
Row Level Temporal Locality (RLTL)
- **Key Idea**: Track recently-accessed DRAM rows and use lower timing parameters if such rows are accessed again
- **ChargeCache**:
 - Low cost & no modifications to the DRAM
 - Higher performance (**8.6-10.6%** on average for 8-core)
 - Lower DRAM energy (**7.9%** on average)

Outline

1. DRAM Operation Basics

2. Accessing Highly-charged Rows

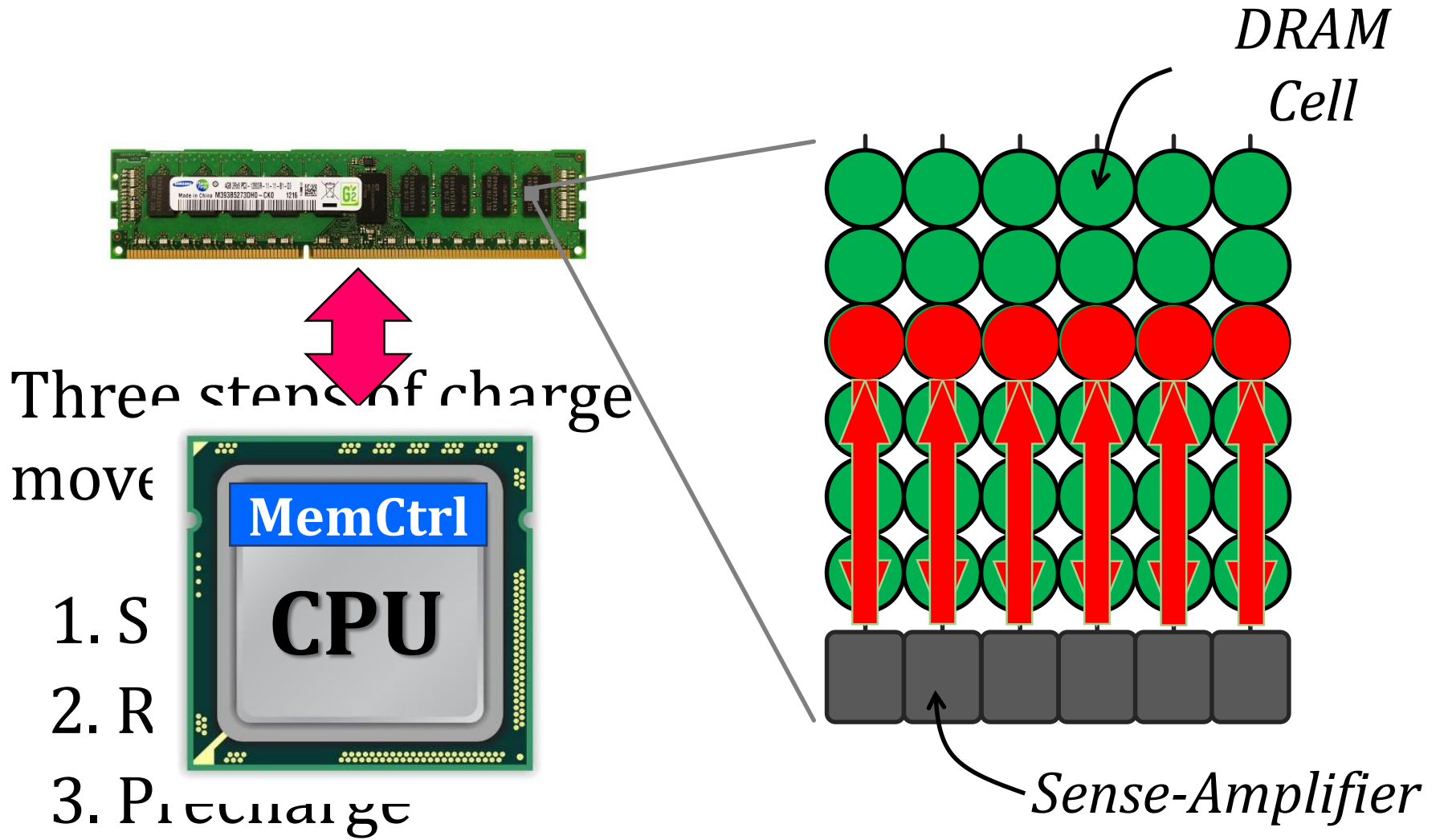
3. Row Level Temporal Locality (RLTL)

4. ChargeCache

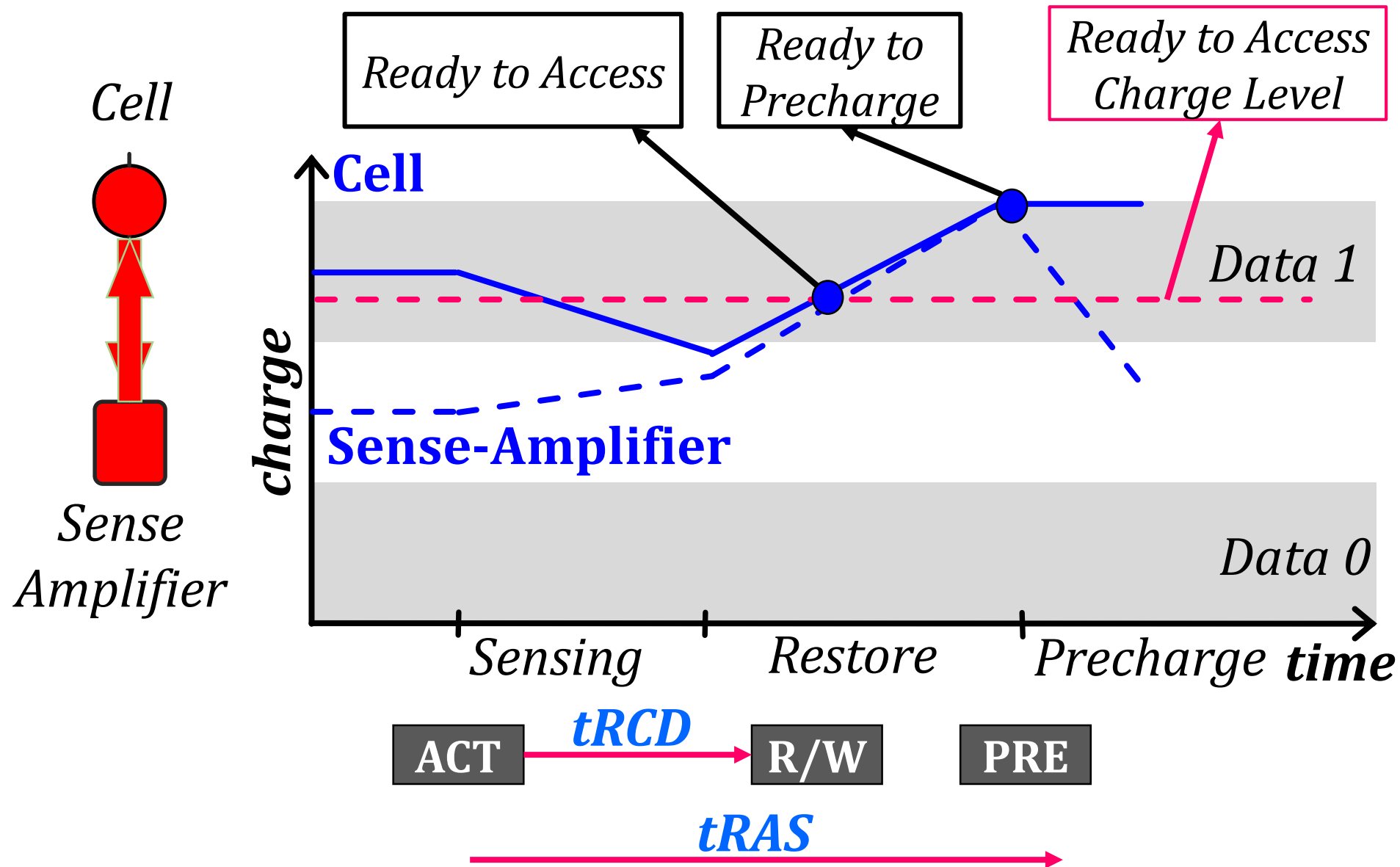
5. Evaluation

6. Conclusion

DRAM Stores Data as Charge



DRAM Charge over Time



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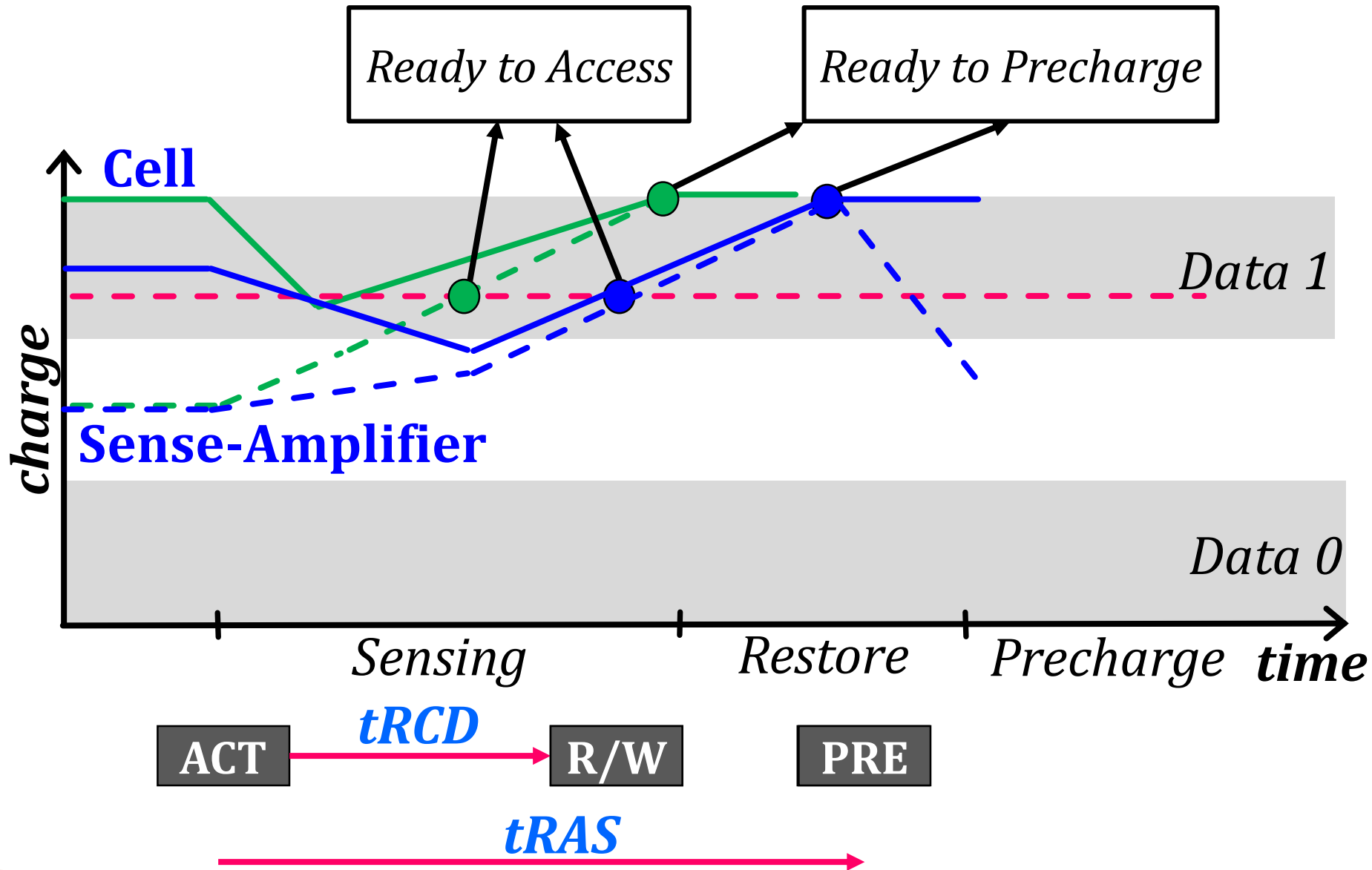
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Accessing Highly-charged Rows



Observation 1

A **highly-charged** DRAM row can be accessed with **low latency**

- tRCD: 44%
- tRAS: 37%



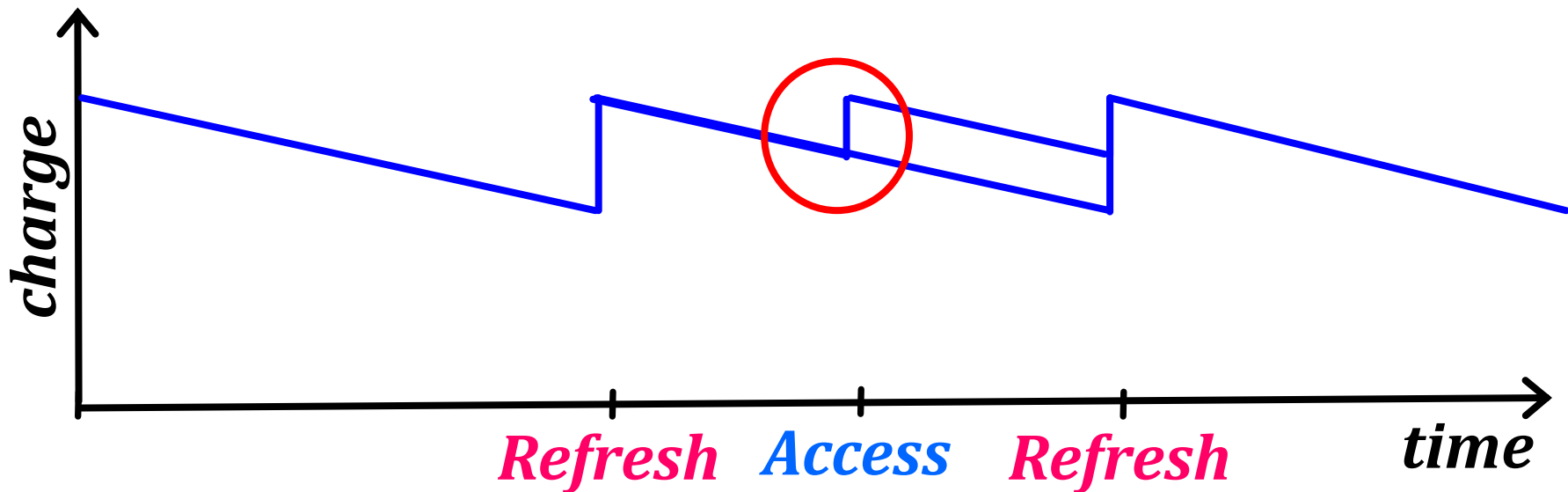
**How does a row become
highly-charged?**

How Does a Row Become Highly-Charged?

DRAM cells **lose charge** over time

Two ways of restoring a row's charge:

- Refresh Operation
- Access



Observation 2

A row's charge is **restored** when the row is **accessed**

How likely is a **recently-accessed row to be accessed again?**

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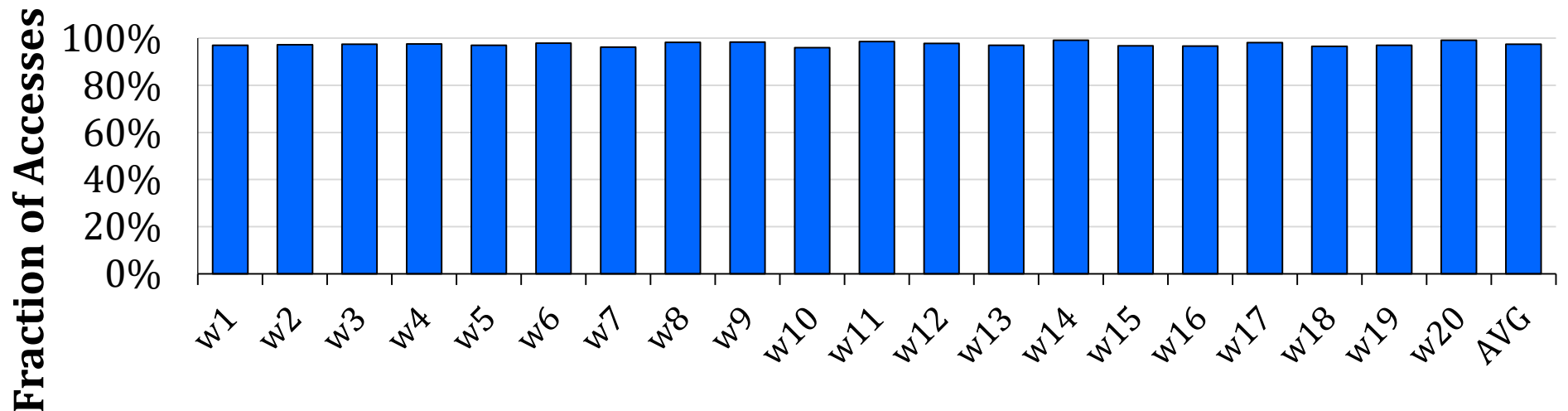
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Row Level Temporal Locality (RLTL)

A **recently-accessed** DRAM row is likely to be accessed again.

- t -RLTL: Fraction of rows that are accessed within time t after their previous access



88ns — RLTL for eight-core workloads

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Summary of the Observations

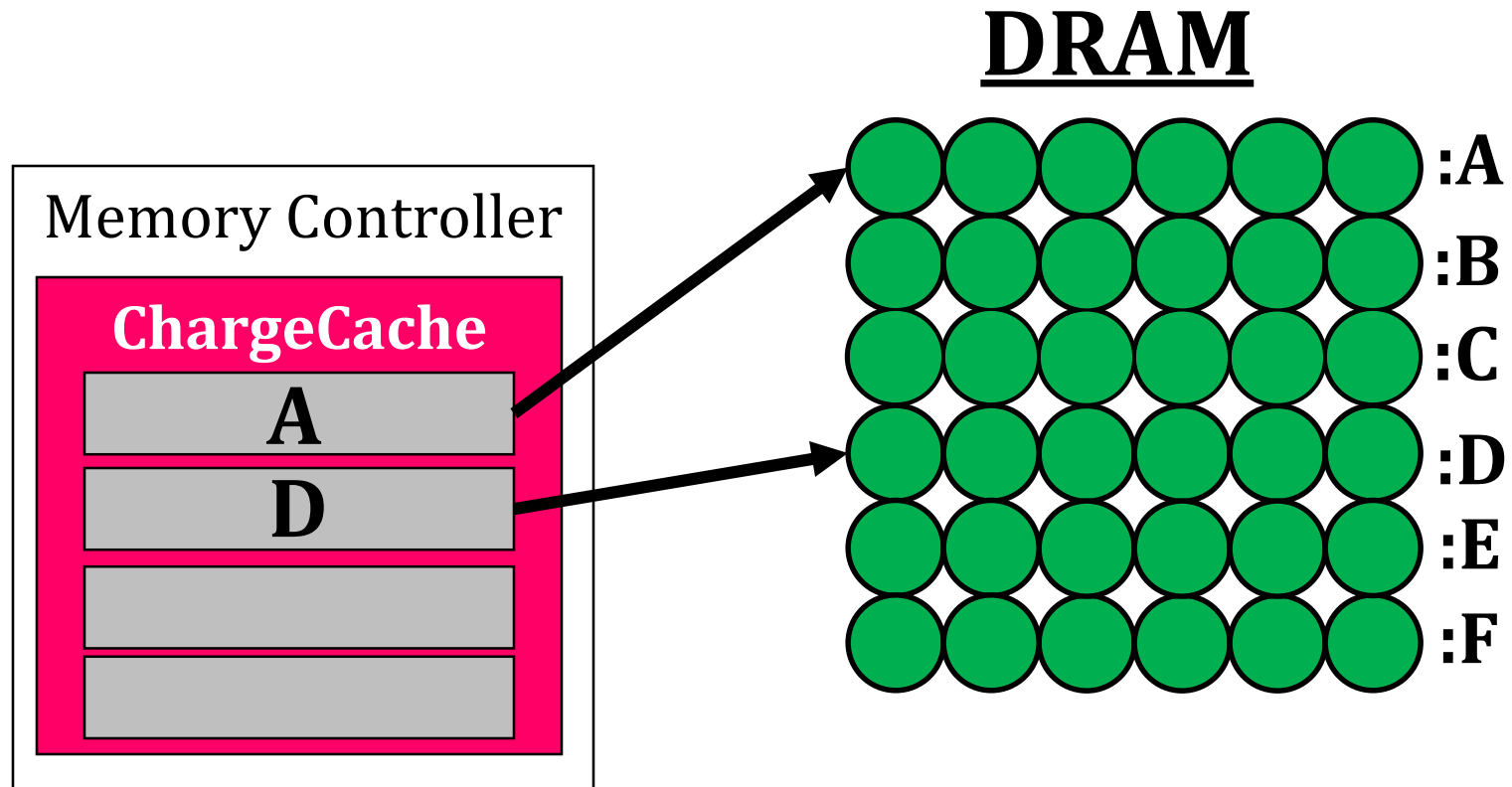
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2. A row's charge is **restored** when the row is **accessed**
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Row Level Temporal Locality (RLTL)

Key Idea

Track **recently-accessed** DRAM rows and use **lower timing parameters** if such rows are accessed again

ChargeCache Overview



Requests: A D A 

ChargeCache Hits: Use Lowert Timings

Area and Power Overhead

- **Modeled with CACTI**

- **Area**

- ~5KB for 128-entry ChargeCache
- **0.24%** of a 4MB Last Level Cache (LLC) area

- **Power Consumption**

- 0.15 mW on average (static + dynamic)
- **0.23%** of the 4MB LLC power consumption

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Methodology

- **Simulator**

- Ramulator *[Kim+, CAL'15]*

<https://github.com/CMU-SAFARI/ramulator>

- **Workloads**

- 22 single-core workloads

- SPEC CPU2006, TPC, STREAM

- 20 multi-programmed 8-core workloads

- By randomly choosing from single-core workloads

- Execute at least 1 billion representative instructions per core (Pinpoints)

- **System Parameters**

- 1/8 core system with 4MB LLC

- Default tRCD/tRAS of 11/28 cycles

Mechanisms Evaluated

Non-Uniform Access Time Memory Controller (NUAT)

[Shin+, HPCA'14]

- **Key idea:** Access only *recently-refreshed* rows with lower timing parameters
- *Recently-refreshed* rows can be accessed faster
- Only a small fraction (10-12%) of accesses go to *recently-refreshed* rows

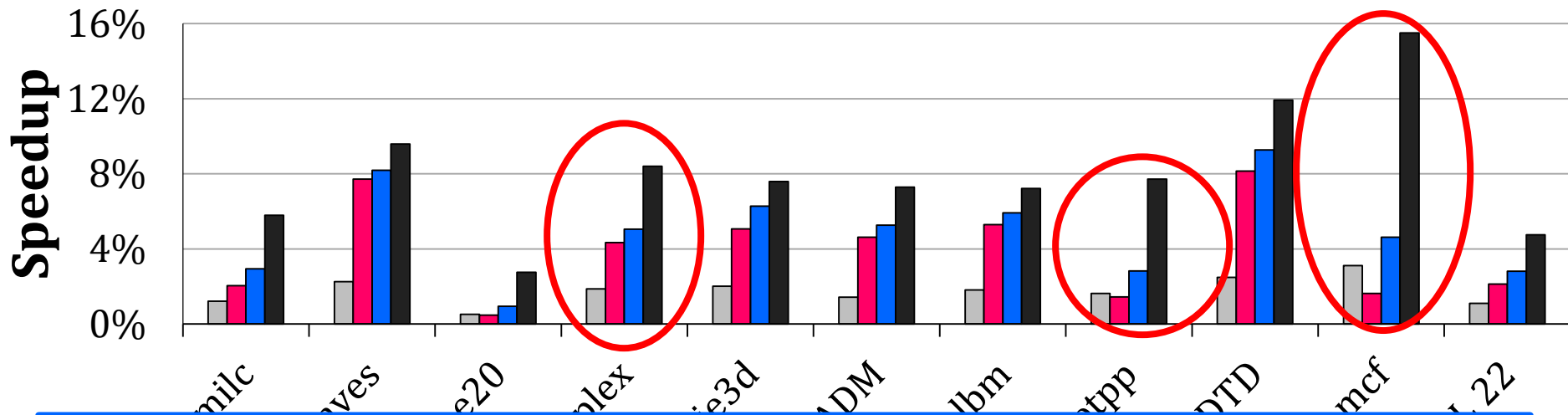
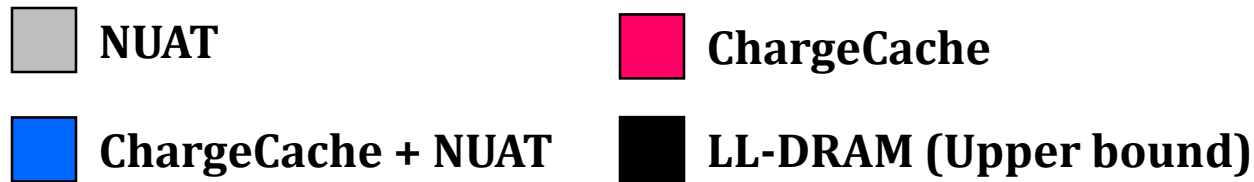
ChargeCache

- *Recently-accessed* rows can be accessed faster
- A large fraction (86-97%) of accesses go to *recently-accessed* rows (*RLTL*)
- 128 entries per core, **On hit:** tRCD-7, tRAS-20 cycles

Upper Bound: Low Latency DRAM

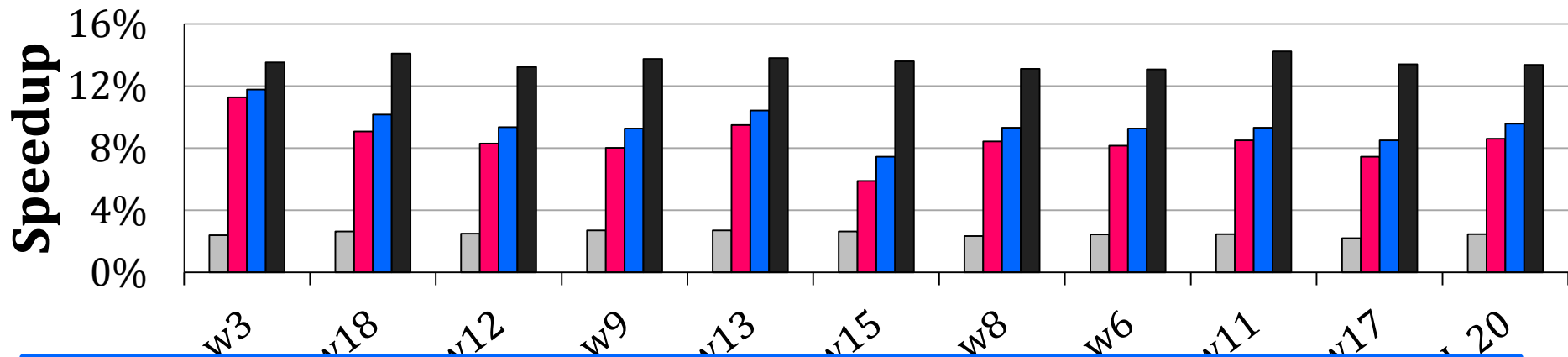
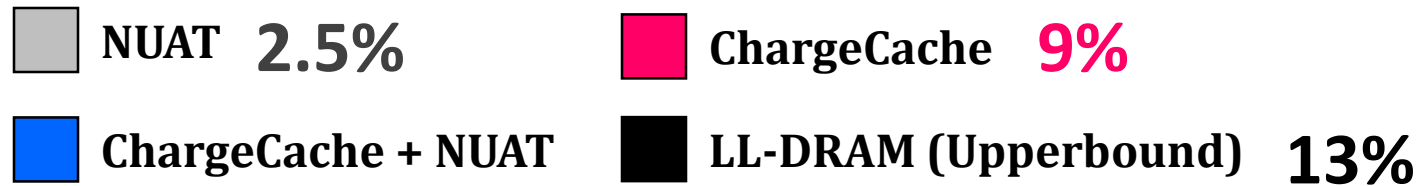
- Works as ChargeCache with 100% Hit Ratio
- **On all DRAM accesses:** tRCD-7, tRAS-20 cycles

Single-core Performance



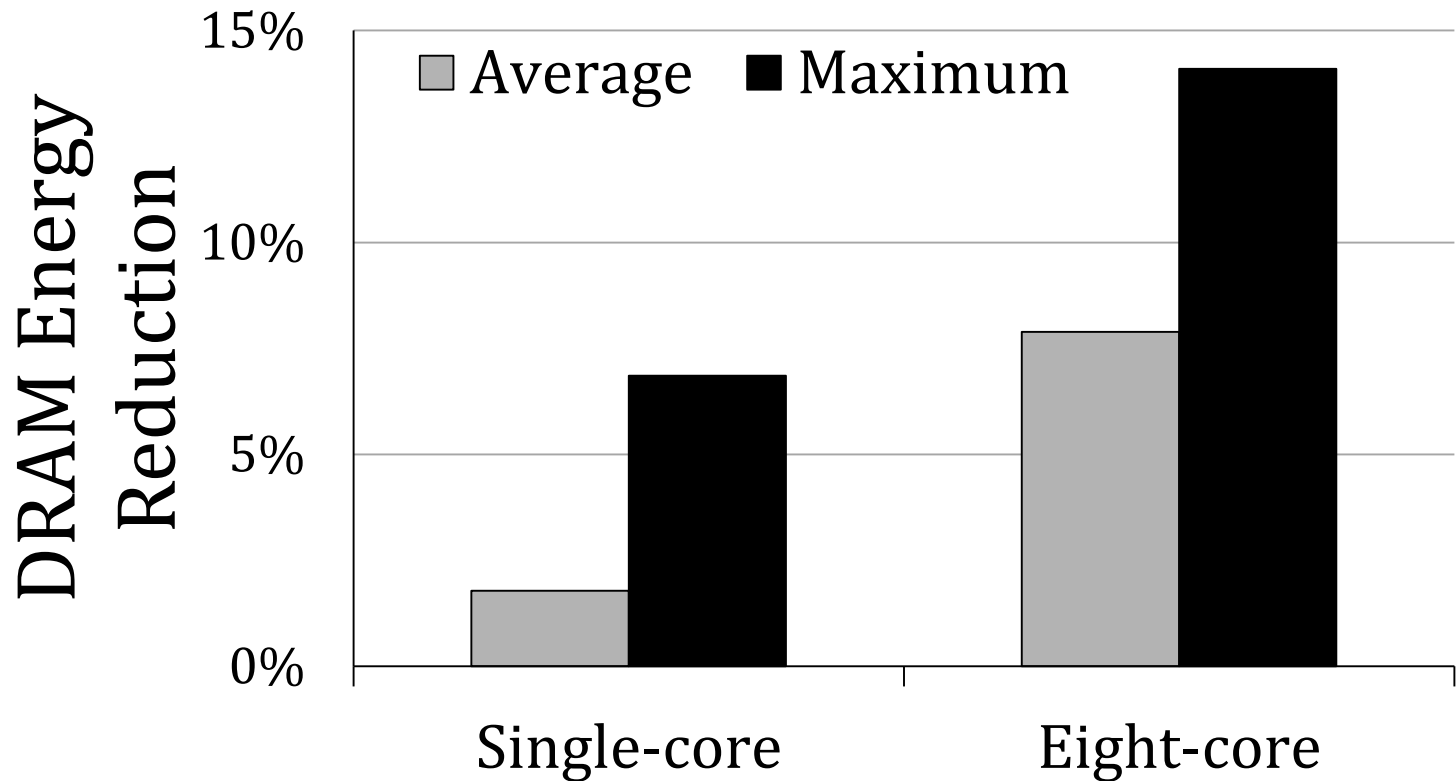
ChargeCache improves single-core performance

Eight-core Performance



ChargeCache significantly improves multi-core performance

DRAM Energy Savings



ChargeCache reduces DRAM energy

Other Results In The Paper

- Detailed analysis of the Row Level Temporal Locality phenomenon
- ChargeCache hit-rate analysis
- Sensitivity studies
 - Sensitivity to t in t -RLTL
 - ChargeCache capacity

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Conclusion

- ChargeCache **reduces** average DRAM access latency at **low cost**
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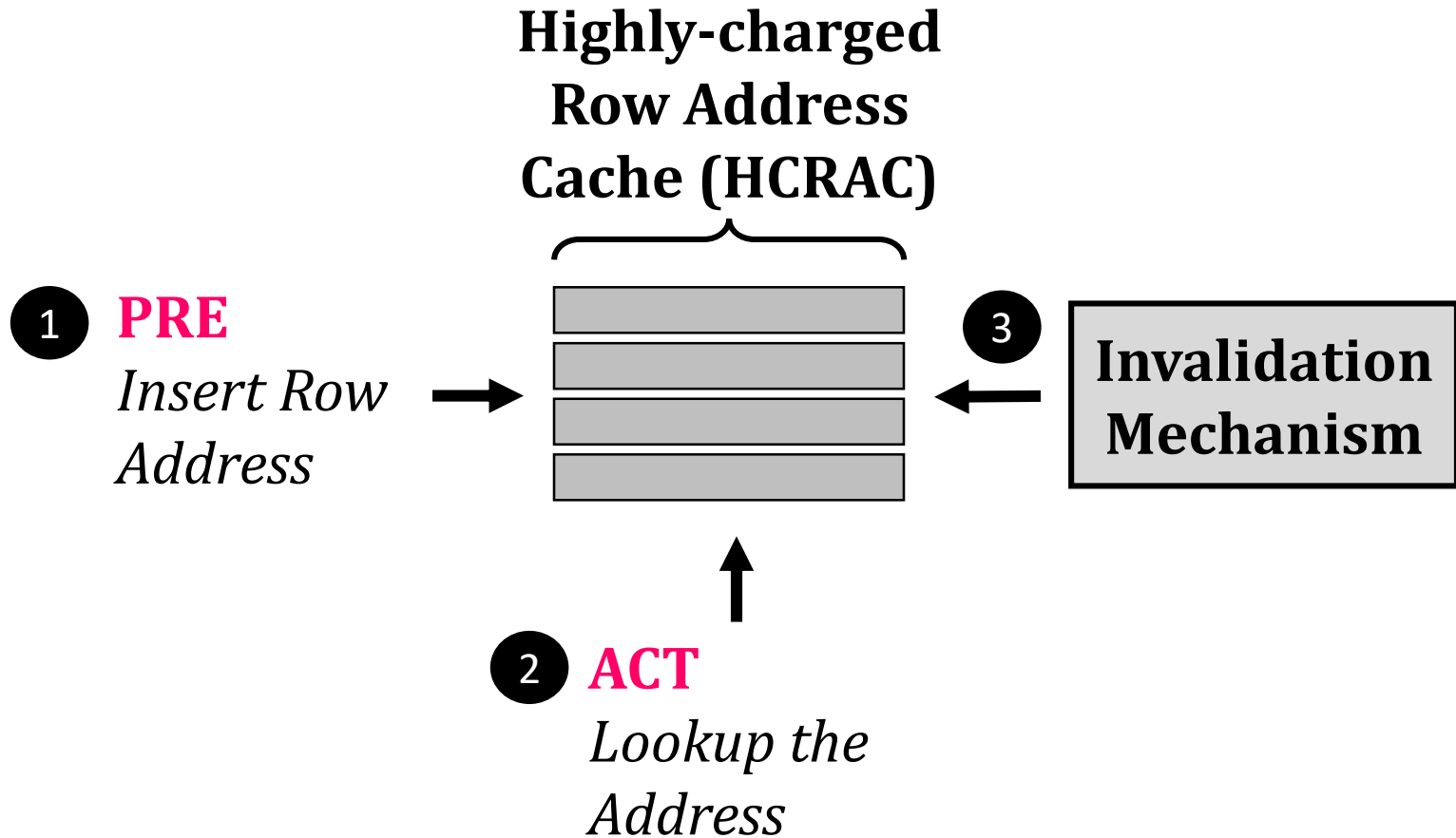


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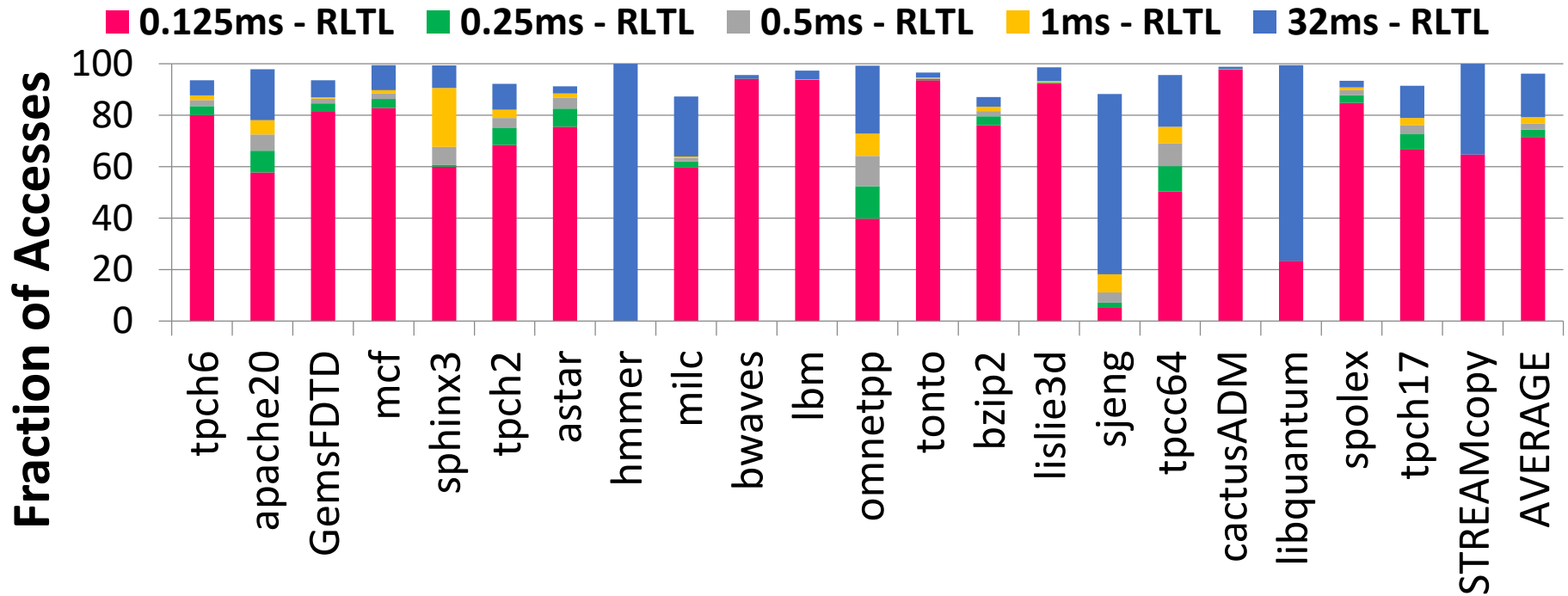


Backup Slides

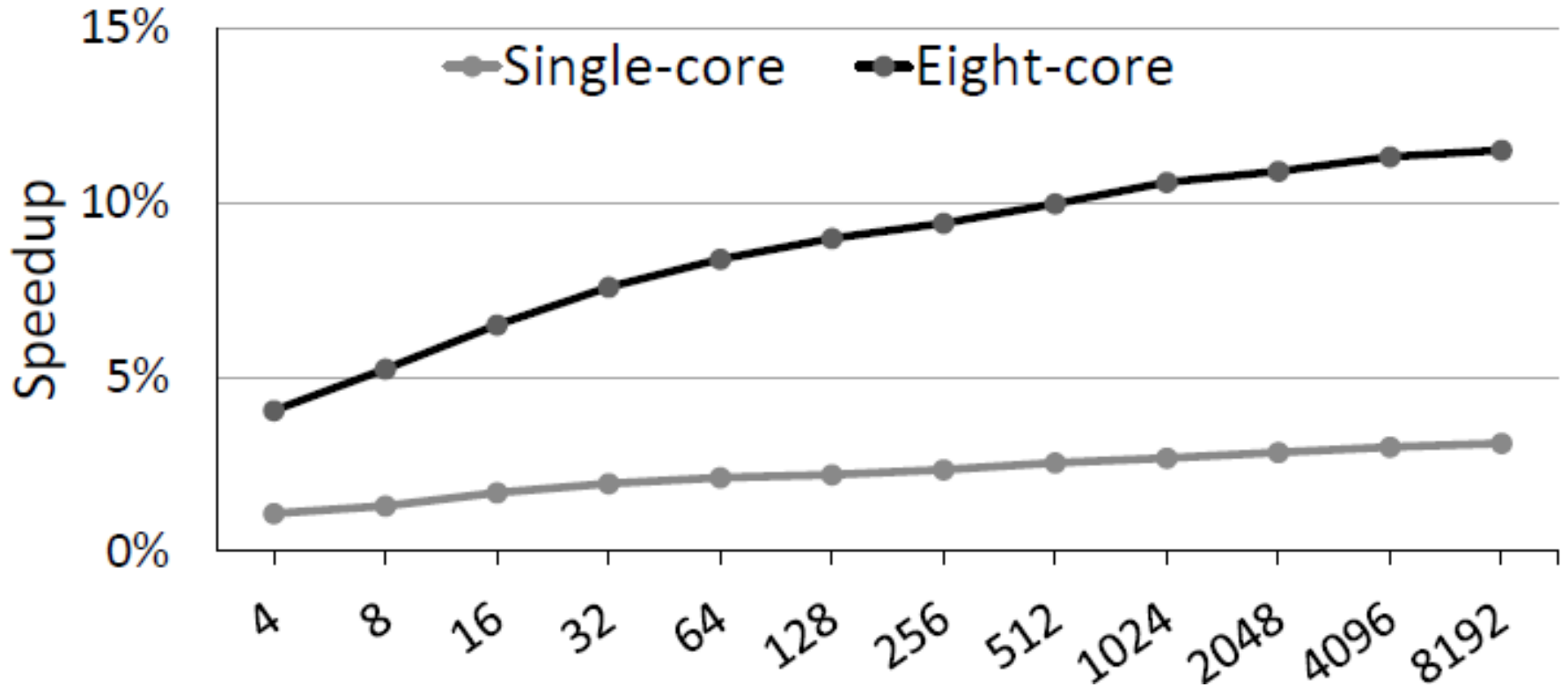
Detailed Design



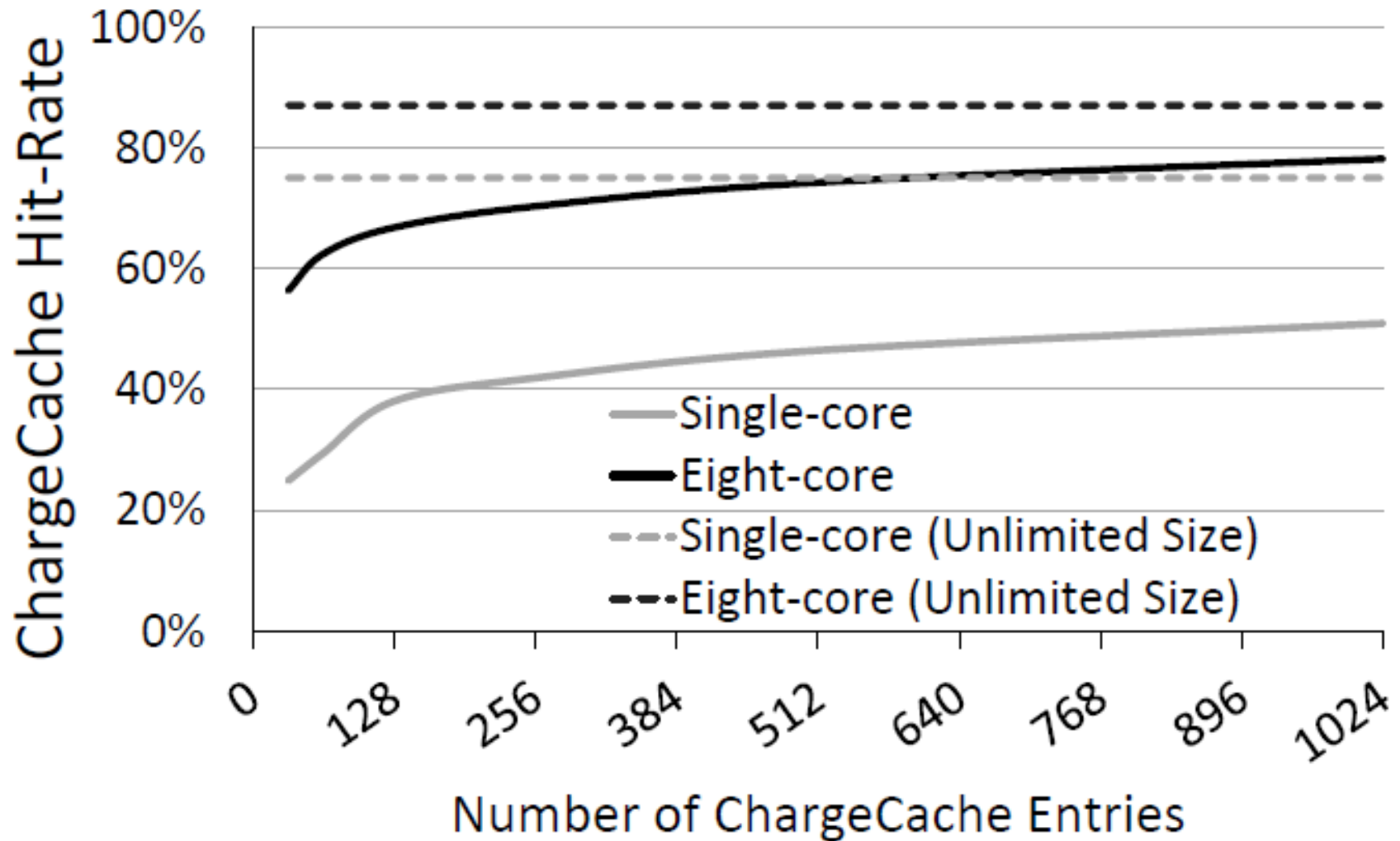
RLTL Distribution



Sensitivity on Capacity



Hit-rate Analysis



Sensitivity on t-RLTL

